

### Door actuator driver

#### **Features**

- Three half bridges for 0.75 A loads  $(R_{DSon} = 1600 \text{ m}\Omega)$
- Two configurable high-side driver for up to 1.5A load ( $R_{DSon} = 500 \text{ m}\Omega$ ) or 0.35 A load ( $R_{on} = 1800 \text{ m}\Omega$ )
- One high-side driver for 6 A load  $(R_{DSon} = 100 \text{ m}\Omega)$
- Programmable soft start function to drive loads with higher inrush currents (i.e. current > 6 A, current > 1.5 A)
- Very low current consumption in standby mode (I<sub>S</sub> < 6 µA typ; T<sub>i</sub> ≤ 85 °C)
- All outputs short circuit protected
- Current monitor output for high-side OUT1, OUT4, OUT5 and OUT6
- All outputs over temperature protected
- Open-load diagnostic for all outputs
- Overload diagnostic for all outputs
- PWM control of all outputs
- Charge pump output for reverse polarity protection



# **Applications**

 Door actuator driver with bridges for mirror axis control and high-side driver for mirror defroster and two 10 W light bulbs and/or LEDs.

#### Description

The L9954LXP is a microcontroller driven multifunctional door actuator driver for automotive applications. Up to two DC motors and three grounded resistive loads can be driven with three half bridges and three high-side drivers. The integrated standard Serial Peripheral Interface (SPI) controls all operation modes (forward, reverse, brake and high impedance). All diagnostic information is available via SPI.

Table 1. Device summary

Package	Order codes		
rackage	Tube	Tape and reel	
PowerSSO-36	L9954LXP	L9954LXPTR	

Contents L9954LXP

# **Contents**

1	Bloc	k diagram and pin description	6
2	Elect	trical specifications	9
	2.1	Absolute maximum ratings	9
	2.2	ESD protection	9
	2.3	Thermal data	9
	2.4	Electrical characteristics	10
	2.5	SPI - electrical characteristics	14
3	Appl	lication information	20
	3.1	Dual power supply: VS and VCC	20
	3.2	Standby mode	20
	3.3	Inductive loads	20
	3.4	Diagnostic functions	20
	3.5	Overvoltage and under voltage detection	21
	3.6	Charge pump	21
	3.7	Temperature warning and thermal shutdown	21
	3.8	Open-load detection	21
	3.9	Overload detection	21
	3.10	Current monitor	22
	3.11	PWM inputs	22
	3.12	Cross-current protection	22
	3.13	Programmable soft start function to drive loads with higher inrush current	23
4	Fund	ctional description of the SPI	24
	4.1	Serial Peripheral Interface (SPI)	24
	4.2	Chip Select Not (CSN)	24
	4.3	Serial Data In (DI)	24
	4.4	Serial Data Out (DO)	24
	4.5	Serial Clock (CLK)	25
	4.6	Input Data Register	25

Contents

	4.7 4.8	Status register
5	Pack	rages thermal data
6	Pack	rage and packing information
	6.1	ECOPACK® packages
	6.2	PowerSSO-36 package information
	6.3	PowerSSO-36 packing information
7	Revi	sion history

List of tables L9954LXP

# List of tables

Table 1.	Device summary	1
Table 2.	Pin definitions and functions	7
Table 3.	Absolute maximum ratings	9
Table 4.	ESD protection	9
Table 5.	Operating junction temperature	9
Table 6.	Temperature warning and thermal shutdown	. 10
Table 7.	Supply	. 10
Table 8.	Overvoltage and under voltage detection	. 11
Table 9.	Current monitor output	. 11
Table 10.	Charge pump output	. 12
Table 11.	OUT1 - OUT6	
Table 12.	Delay time from standby to active mode	. 14
Table 13.	Inputs: CSN, CLK, PWM1/2 and DI	. 15
Table 14.	DI timing	. 15
Table 15.	DO	. 15
Table 16.	DO timing	. 16
Table 17.	CSN timing	. 16
Table 18.	SPI - input data and status registers 0	. 26
Table 19.	SPI - input data and status registers 1	. 28
Table 20.	PowerSSO-36 mechanical data	. 32
Table 21.	Document revision history	. 34

L9954LXP List of figures

# List of figures

Figure 1.	Block diagram	6
Figure 2.	Configuration diagram (top view)	6
Figure 3.	SPI - transfer timing diagram	17
Figure 4.	SPI - input timing	17
Figure 5.	SPI - DO valid data delay time and valid time	18
Figure 6.	SPI - DO enable and disable time	18
Figure 7.	SPI - driver turn-on / off timing, minimum CSN HI time	19
Figure 8.	SPI - timing of status bit 0 (fault condition)	19
Figure 9.	Programmable soft start function for inductive loads and incandescent bulbs	23
Figure 10.	Packages thermal data	30
Figure 11.	PowerSSO-36 package dimensions	31
Figure 12.	PowerSSO-36 tube shipment (no suffix)	33
Figure 13.	PowerSSO-36 tape and reel shipment (suffix "TR")	33

# Block diagram and pin description

Figure 1. **Block diagram** 

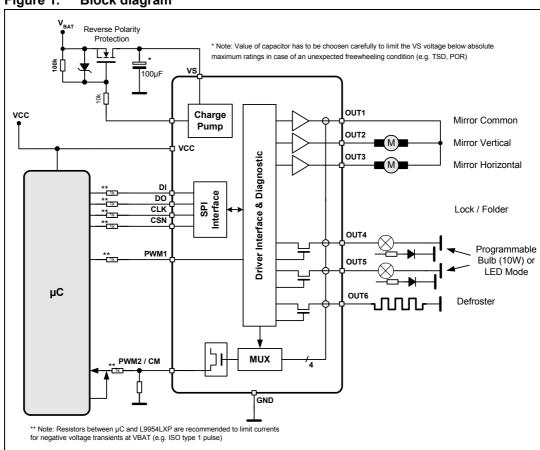
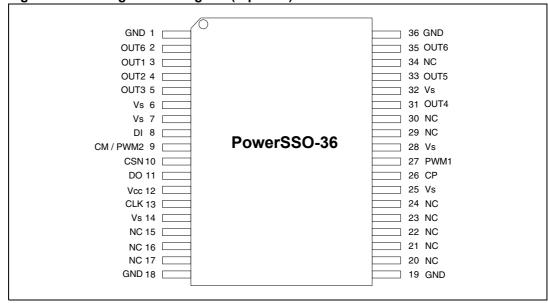


Figure 2. Configuration diagram (top view)



6/35

Table 2. Pin definitions and functions

Pin	Symbol	Function
1, 18, 19, 36	GND	Ground: reference potential. Important: for the capability of driving the full current at the outputs all pins of GND must be externally connected.
2, 35	OUT6	High-side driver output 6 The output is built by a high-side switch and is intended for resistive loads, hence the internal reverse diode from GND to the output is missing. For ESD reason a diode to GND is present but the energy which can be dissipated is limited. The high-side driver is a power DMOS transistor with an internal parasitic reverse diode from the output to V <sub>S</sub> (bulk-drain-diode). The output is over-current and openload protected.  Important: for the capability of driving the full current at the outputs both pins of OUT6 must be externally connected.
3 4 5	OUT1 OUT2 OUT3	Half-bridge output 1,2,3 The output is built by a high-side and a low-side switch, which are internally connected. The output stage of both switches is a power DMOS transistor. Each driver has an internal parasitic reverse diode (bulk-drain-diode: high-side driver from output to V <sub>S</sub> , switchs driver from GND to output). This output is over-current and open-load protected.
6, 7, 14, 25, 28, 32	V <sub>S</sub>	Power supply voltage (external reverse protection required) For this input a ceramic capacitor as close as possible to GND is recommended. Important: for the capability of driving the full current at the outputs all pins of V <sub>S</sub> must be externally connected.
8	DI	Serial data input The input requires CMOS logic levels and receives serial data from the microcontroller. The data is an 24bit control word and the least significant bit (LSB, bit 0) is transferred first.
9	CM/PWM2	Current monitor output/PWM2 input  Depending on the selected multiplexer bits of input data register this output sources an image of the instant current through the corresponding high-side driver with a ratio of 1/10.000. This pin is bidirectional. The microcontroller can overdrive the current monitor signal to provide a second PWM input for the output OUT5.
10	CSN	Chip select not input This input is low active and requires CMOS logic levels. The serial data transfer between L9954LXP and micro controller is enabled by pulling the input CSN to low-level.
11	DO	Serial data output The diagnosis data is available via the SPI and this 3-state output. The output remains in 3-state, if the chip is not selected by the input CSN (CSN = high)

Table 2. Pin definitions and functions (continued)

Pin	Symbol	Function
12	V <sub>CC</sub>	Logic supply voltage For this input a ceramic capacitor as close as possible to GND is recommended.
13	CLK	Serial clock input This input controls the internal shift register of the SPI and requires CMOS logic levels.
26	СР	Charge pump output This output is provided to drive the gate of an external n-channel power MOS used for reverse polarity protection.
27	PWM1	PWM1 input This input signal can be used to control the drivers OUT1-OUT4 and OUT6 by an external PWM signal.
31 33	OUT4, OUT5	High-side driver output 4 and 5 Each output is built by a high-side switch and is intended for resistive loads, hence the internal reverse diode from GND to the output is missing. For ESD reason a diode to GND is present but the energy which can be dissipated is limited. Each high-side driver is a power DMOS transistor with an internal parasitic reverse diode from each output to $V_{\rm S}$ (bulk-drain-diode). Each output is over-current and openload protected.
15, 16, 17, 20, 21, 22, 23, 24, 29, 30, 34	NC	Not connected pins.

8/35 Doc ID 16186 Rev 2

# 2 Electrical specifications

# 2.1 Absolute maximum ratings

Stressing the device above the rating listed in the "Absolute maximum ratings" table may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in the Operating sections of this specification is not implied. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability. Refer also to the STMicroelectronics SURE Program and other relevant quality document

Table 3. Absolute maximum ratings

Symbol Parameter		Value	Unit
V	DC supply voltage	-0.3 to 28	V
$V_S$	Single pulse t <sub>max</sub> < 400 ms	40	V
V <sub>CC</sub>	Stabilized supply voltage, logic supply	-0.3 to 5.5	V
V <sub>DI</sub> , V <sub>DO,</sub> V <sub>CLK</sub> , V <sub>CSN,</sub> V <sub>pwm1</sub>	Digital input / output voltage	-0.3 to V <sub>CC</sub> + 0.3	V
V <sub>CM</sub>	Current monitor output	-0.3 to V <sub>CC</sub> + 0.3	V
V <sub>CP</sub>	Charge pump output	-25 to V <sub>S</sub> + 11	V
I <sub>OUT1,2,3,4,5</sub>	Output current	±5	Α
I <sub>OUT6</sub>	Output current	±10	Α

# 2.2 ESD protection

Table 4. ESD protection

Parameter	Value	Unit
All pins	± 2 <sup>(1)</sup>	kV
Output pins: OUT1 - OUT6	± 8 <sup>(2)</sup>	kV

<sup>1.</sup> HBM according to MIL 883C, Method 3015.7 or EIA/JESD22-A114-A.

#### 2.3 Thermal data

Table 5. Operating junction temperature

Symbol	Parameter	Value	Unit
T <sub>j</sub>	Operating junction temperature	-40 to 150	°C

<sup>2.</sup> HBM with all unzapped pins grounded.

Table 6. Temperature warning and thermal shutdown

Symbol	Parameter		Min.	Тур.	Max.	Unit
T <sub>jTW On</sub>	Temperature warning threshold junction temperature	Tj	130		150	°C
T <sub>jSD On</sub>	Thermal shutdown threshold junction temperature	T <sub>j</sub> increasing			170	°C
T <sub>jSD Off</sub>	Thermal shutdown threshold junction temperature	T <sub>j</sub> decreasing	150			°C
T <sub>jSD HYS</sub>	Thermal shutdown hysteresis			5		°K

# 2.4 Electrical characteristics

Values specified in this section are for  $V_S = 8$  to 16 V,  $V_{CC} = 4.5$  to 5.3 V,  $T_j = -40$  to 150 °C, unless otherwise specified. The voltages are referred to GND and currents are assumed positive, when the current flows into the pin.

Table 7. Supply

Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
Vs	Operating supply voltage range		7		28	٧
	V <sub>S</sub> DC supply current	V <sub>S</sub> = 16 V, V <sub>CC</sub> = 5.3 V active mode OUT1 - OUT6 floating		7	20	mA
I <sub>S</sub>	V <sub>S</sub> quiescent supply current	$V_S = 16 \text{ V}, V_{CC} = 0 \text{ V}$ standby mode OUT1 - OUT6 floating $T_{test} = -40 ^{\circ}\text{C}, 25 ^{\circ}\text{C}$		4	12	μΑ
		T <sub>test</sub> = 85 °C <sup>(1)</sup>		6	25	μΑ
	V <sub>CC</sub> DC supply current	$V_S = 16 \text{ V}, V_{CC} = 5.3 \text{ V}$ CSN = $V_{CC}$ , active mode		1	3	mA
I <sub>CC</sub>	V <sub>CC</sub> quiescent supply current	$V_S = 16 \text{ V}, V_{CC} = 5.3 \text{ V}$ $CSN = V_{CC} \text{ standby mode}$ $OUT1 - OUT6 \text{ floating}$		25	50	μΑ
I <sub>S</sub> + I <sub>CC</sub>	Sum quiescent supply current	$V_S = 16 \text{ V}, V_{CC} = 5.3 \text{ V}$ $CSN = V_{CC}$ standby mode $OUT1 - OUT6 \text{ floating}$ $T_{test} = 130 \text{ °C}$		50	200	μΑ

<sup>1.</sup> Guaranteed by design.

Table 8. Overvoltage and under voltage detection

Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
V <sub>SUV On</sub>	V <sub>S</sub> UV-threshold voltage	V <sub>S</sub> increasing	5.7		7.2	V
V <sub>SUV Off</sub>	V <sub>S</sub> UV-threshold voltage	V <sub>S</sub> decreasing	5.5		6.9	V
V <sub>SUV hyst</sub>	V <sub>S</sub> UV-hysteresis	V <sub>SUV On</sub> - V <sub>SUV Off</sub>		0.5		V
V <sub>SOV Off</sub>	V <sub>S</sub> OV-threshold voltage	V <sub>S</sub> increasing	18		24.5	V
V <sub>SOV On</sub>	V <sub>S</sub> OV-threshold voltage	V <sub>S</sub> decreasing	17.5		23.5	V
V <sub>SOV hyst</sub>	V <sub>S</sub> OV-hysteresis	V <sub>SOV Off</sub> - V <sub>SOV On</sub>		1		V
V <sub>POR Off</sub>	Power-on reset threshold	V <sub>CC</sub> increasing			4.4	V
V <sub>POR On</sub>	Power-on reset threshold	V <sub>CC</sub> decreasing	3.1			V
V <sub>POR hyst</sub>	Power-on reset hysteresis	V <sub>POR Off</sub> - V <sub>POR On</sub>		0.3		٧

Table 9. Current monitor output

Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
V <sub>CM</sub>	Functional voltage range	V <sub>CC</sub> = 5 V	0		4	V
I <sub>CM,r</sub>	Current monitor output ratio: I <sub>CM</sub> / I <sub>OUT6</sub>	$0 \text{ V} \leq \text{V}_{\text{CM}} \leq 4 \text{ V},$ $\text{V}_{\text{CC}} = 5 \text{ V}$		1 10000		-
	Current monitor output ratio: I <sub>CM</sub> / I <sub>OUT1</sub>			<u>1</u> 3800		
	Current monitor output ratio: I <sub>CM</sub> / I <sub>OUT4,5</sub> Iow R <sub>DSon</sub> mode			1 10200		
	Current monitor output ratio:  I <sub>CM</sub> / I <sub>OUT4,5</sub> high R <sub>DSon</sub> mode			<u>1</u> 2400		

Table 9. Current monitor output (continued)

Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
	Current monitor accuracy Acc I <sub>CM</sub> / I <sub>OUT 8</sub>	$ \begin{aligned} 0 \ V &\leq V_{CM} \leq 3.8 \ V, \\ V_{CC} &= 5 \ V, \\ I_{Out,min \ 8} &= 0.5 \ A, \\ I_{Out \ max \ 8} &= 5.9 \ A \end{aligned} $			8%+	
	Current monitor accuracy Acc I <sub>CM</sub> / I <sub>OUT 1</sub>	$ \begin{aligned} 0 & \text{V} \leq \text{V}_{CM} \leq 3.8 \text{ V}, \\ \text{V}_{CC} &= 5\text{V}, \\ \text{I}_{Out,min 1} &= 60\text{mA}, \\ \text{I}_{Out \max 1} &= 0.6\text{A} \end{aligned} $		4% +		_
<sup>I</sup> CM acc	Current monitor accuracy Acc I <sub>CM</sub> / I <sub>OUT 4,5</sub> high R <sub>DSon</sub> mode	$ \begin{aligned} 0 & \text{V} \leq \text{V}_{CM} \leq 3.8 \text{ V}, \\ \text{V}_{CC} = 5 & \text{V}, \\ \text{I}_{Out, min \ 4,5} = 30 \text{ mA}, \\ \text{I}_{Out \ max \ 4,5} = 300 \text{ mA} \end{aligned} $	1%FS	2%FS		
	Current monitor accuracy Acc $I_{CM}/I_{OUT~4,5}$ ow $R_{DSon}$ mode $ \begin{array}{c} 0 \ V \leq V_{CM} \leq 3.8 \ V, \\ V_{CC} = 5 \ V, \\ I_{Out,min~4,5} = 150 \ mA, \\ I_{Out~max~4,5} = 1 \ A \end{array} $					

Table 10. Charge pump output

Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
	Charge pump output voltage	$V_S = 8 \text{ V},  I_{CP} = -60  \mu\text{A}$	V <sub>S</sub> +6		V <sub>S</sub> +13	٧
$V_{CP}$		$V_S = 10 \text{ V}, I_{CP} = -80 \mu\text{A}$	V <sub>S</sub> +8		V <sub>S</sub> +13	V
		$V_S \ge 12 \text{ V}, I_{CP} = -100 \mu\text{A}$	V <sub>S</sub> +10		V <sub>S</sub> +13	٧
I <sub>CP</sub>	Charge pump output current	$V_{CP} = V_S + 10 \text{ V},$ $V_S = 13.5 \text{ V}$	95	150	300	μΑ

Table 11. OUT1 - OUT6

Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
R <sub>DSon OUT1</sub> , R <sub>DSon OUT2</sub> R <sub>DSon OUT3</sub>	GND	$V_S = 13.5 \text{ V}, T_j = 25 \text{ °C},$ $I_{OUT1,2,3} = \pm 0.4 \text{ A}$		1600	2200	mΩ
		$V_S = 13.5 \text{ V}, T_j = 125 \text{ °C},$ $I_{OUT1,2,3} = \pm 0.4 \text{ A}$		2500	3400	mΩ
R <sub>DSon OUT4</sub> , R <sub>DSon OUT5</sub>	On resistance to supply in low R <sub>DSon</sub> mode	$V_S = 13.5 \text{ V}, T_j = 25 \text{ °C},$ $I_{OUT4,5} = -0.8 \text{ A}$		500	700	mΩ
		$V_S = 13.5 \text{ V}, T_j = 125 \text{ °C},$ $I_{OUT4,5} = -0.8 \text{ A}$		700	950	mΩ
	On resistance in high R <sub>DSon</sub> mode	$T_j = 25  ^{\circ}\text{C},  I_{\text{OUT4,5}} = -0.2  \text{A}$		2000	2700	$m\Omega$
		$T_j = 125  ^{\circ}\text{C},  I_{\text{OUT4,5}} = -0.2  \text{A}$		3200	4300	$m\Omega$

Table 11. OUT1 - OUT6 (continued)

Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
P	On resistance to supply	$V_S = 13.5 \text{ V}, T_j = 25 \text{ °C},$ $I_{OUT6} = -3 \text{ A}$		100	150	mΩ
R <sub>DSon OUT6</sub>	Of resistance to supply	$V_S = 13.5 \text{ V}, T_j = 125 \text{ °C},$ $I_{OUT6} = -3 \text{ A}$		150	200	mΩ
I <sub>OUT1</sub> I <sub>OUT2</sub> I <sub>OUT3</sub>	Output current limitation to GND	Source, V <sub>S</sub> = 13.5 V	-1.25		-0.75	Α
I <sub>OUT1</sub> I <sub>OUT2</sub> I <sub>OUT3</sub>	Output current limitation to supply	Sink, V <sub>S</sub> = 13.5 V	0.75		1.25	Α
I <sub>OUT4</sub>	Output current limitation to GND in low R <sub>DSon</sub> mode	Source, V <sub>S</sub> = 13.5 V	-3.0		-1.5	Α
Іоит5	Output current limitation to GND in high R <sub>DSon</sub> mode		-0.65		-0.35	Α
I <sub>OUT6</sub>	Output current limitation to GND	Source, V <sub>S</sub> = 13.5 V	-10.5		-6	Α
t <sub>d On H</sub>	Output delay time, high- side driver on	V <sub>S</sub> = 13.5 V, R <sub>load</sub> = <sup>(1)</sup> corresponding low-side driver is not active	10	40	80	μs
t <sub>d Off H</sub>	Output delay time, high- side driver off	$V_S = 13.5 \text{ V}, R_{load} = {}^{(2)}$	15	150	300	μs
<sup>t</sup> d On L	Output delay time, low- side driver on	V <sub>S</sub> = 13.5 V, R <sub>load</sub> = <sup>(2)</sup> corresponding high-side driver is not active	15	30	70	μs
t <sub>d Off L</sub>	Output delay time, low- side driver off	$V_S = 13.5 \text{ V}, R_{load} = {}^{(2)}$	20	150	300	μs
t <sub>d HL</sub>	Cross current protection time, source to sink	tCC ONLS_OFFHS - td Off H (2)		200	400	μs
t <sub>d LH</sub>	Cross current protection time, sink to source	t <sub>CC ONHS_OFFLS</sub> - t <sub>d OFF L</sub> <sup>(2)</sup>		200	400	μs
		V <sub>OUT1-6</sub> = 0 V, standby mode	-3	0	-3	μΑ
I <sub>QLH</sub>	Switched-off output current high-side drivers of OUT1-6	V <sub>OUT1-2-3-6</sub> = 0 V, active mode	-40	-15	0	μΑ
		V <sub>OUT4-5</sub> = 0 V, active mode	-10	-8	0	μΑ
_	Switched-off output	$V_{OUT1-3} = V_S$ , standby mode	0	80	120	μΑ
I <sub>QLL</sub>	current low-side drivers of OUT1-3	V <sub>OUT1-3</sub> = V <sub>S</sub> , active mode	-40	-15	0	μΑ
I <sub>OLD123</sub>	Open-load detection current of OUT1, OUT2 and OUT3	Source and sink	10	20	30	mA

Table 11. OUT1 - OUT6 (continued)

Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
I <sub>OLD45</sub>	Open-load detection current of OUT4 and OUT5	Source	15	40	60	mA
	Open-load detection current of OUT4 and OUT5 in high R <sub>DSon</sub> mode		5	10	15	mA
I <sub>OLD6</sub>	Open-load detection current of OUT6	Source	30	150	300	mA
t <sub>d</sub> OL	Minimum duration of open-load condition to set the status bit		500		3000	μs
t <sub>ISC</sub>	Minimum duration of over- current condition to switch off the driver		10		100	μs
f <sub>rec0</sub>	Recovery frequency for OC recovery duty cycle bit=0		1		4	kHz
f <sub>rec1</sub>	Recovery frequency for OC recovery duty cycle bit=1		2		6	kHz
dV <sub>OUT123</sub> /dt dV <sub>OUT45</sub> /dt	Slew rate of OUT <sub>123</sub> and OUT <sub>45</sub>	$V_S = 13.5 \text{ V}, R_{load} = {}^{(2)}$	0.1	0.4	0.9	V/µs
dV <sub>OUT6</sub> /dt	Slew rate of OUT <sub>6</sub>	$V_S = 13.5 \text{ V}, R_{load} = {}^{(2)}$	0.08	0.2	0.4	V/µs

<sup>1.</sup> OUT1,2,3 32OHM OUT4,5 16OHM OUT4,5 high RDSon mode 63OHM OUT6 4OHM

### 2.5 SPI - electrical characteristics

Values specified in this section are  $V_S = 8$  to 16 V,  $V_{CC} = 4.5$  to 5.3 V,  $T_j = -40$  to 150 °C, unless otherwise specified. The voltages are referred to GND and currents are assumed positive, when the current flows into the pin.

Table 12. Delay time from standby to active mode

Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
t <sub>set</sub>	Delay time	Switching from standby to active mode. Time until output drivers are enabled after CSN going to high.		160	300	μs

<sup>2.</sup>  $t_{CC\ ON}$  is the switch On delay time  $t_{d\ ON}$  if complement in half bridge has to switch off.

Inputs: CSN, CLK, PWM1/2 and DI Table 13.

Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
V <sub>inL</sub>	Input low-level	V <sub>CC</sub> = 5 V	1.5	2.0		V
V <sub>inH</sub>	Input high-level	V <sub>CC</sub> = 5 V		3.0	3.5	V
V <sub>inHyst</sub>	Input hysteresis	V <sub>CC</sub> = 5 V	0.5			V
I <sub>CSN in</sub>	Pull up current at input CSN	$V_{CSN} = 3.5 \text{ V}, V_{CC} = 5 \text{ V}$	-40	-20	-5	μΑ
I <sub>CLK in</sub>	Pull down current at input CLK	V <sub>CLK</sub> = 1.5 V	10	25	50	μΑ
I <sub>DI in</sub>	Pull down current at input DI	V <sub>DI</sub> = 1.5 V	10	25	50	μΑ
I <sub>PWM1 in</sub>	Pull down current at input PWM1	V <sub>PWM</sub> = 1.5 V	10	25	50	μΑ
C <sub>in</sub> <sup>(1)</sup>	Input capacitance at input CSN, CLK, DI and PWM1/2	0 V < V <sub>CC</sub> < 5.3 V		10	15	pF

<sup>1.</sup> Value of input capacity is not measured in production test. Parameter guaranteed by design.

DI timing (1) Table 14.

Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
t <sub>CLK</sub>	Clock period	V <sub>CC</sub> = 5 V	1000	-		ns
t <sub>CLKH</sub>	Clock high time	V <sub>CC</sub> = 5 V	400	ı		ns
t <sub>CLKL</sub>	Clock low time	V <sub>CC</sub> = 5 V	400	-		ns
t <sub>set CSN</sub>	CSN setup time, CSN low before rising edge of CLK	V <sub>CC</sub> = 5 V	400	-		ns
t <sub>set CLK</sub>	CLK setup time, CLK high before rising edge of CSN	V <sub>CC</sub> = 5 V	400	-		ns
t <sub>set DI</sub>	DI setup time	V <sub>CC</sub> = 5 V	200	-		ns
t <sub>hold DI</sub>	DI hold time	V <sub>CC</sub> = 5 V	200	-		ns
t <sub>r in</sub>	Rise time of input signal DI, CLK, CSN	V <sub>CC</sub> = 5 V		-	100	ns
t <sub>f in</sub>	Fall time of input signal DI, CLK, CSN	V <sub>CC</sub> = 5 V		-	100	ns

<sup>1.</sup> DI timing parameters tested in production by a passed / failed test: Tj = -40  $^{\circ}$ C / +25  $^{\circ}$ C: SPI communication @ 2 MHz. Tj = +125  $^{\circ}$ C SPI communication @ 1.25 MHz.

Table 15. DO

Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
V <sub>DOL</sub>	Output low-level	$V_{CC} = 5 \text{ V}, I_{D} = -2 \text{ mA}$		0.2	0.4	V
V <sub>DOH</sub>	Output high-level	$V_{CC} = 5 \text{ V}, I_D = 2 \text{ mA}$	V <sub>CC</sub> - 0.4	V <sub>CC</sub> - 0.2		V

Table 15. DO (continued)

Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
I <sub>DOLK</sub>	3-state leakage current	$V_{CSN} = V_{CC},$ $0V < V_{DO} < V_{CC}$	-10		10	μА
C <sub>DO</sub> (1)	3-state input capacitance	$V_{CSN} = V_{CC},$ 0 V < $V_{CC}$ < 5.3 V		10	15	pF

<sup>1.</sup> Value of input capacity is not measured in production test. Parameter guaranteed by design.

Table 16. DO timing

Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
t <sub>r DO</sub>	DO rise time	$C_L = 100 \text{ pF}, I_{load} = -1 \text{ mA}$	-	80	140	ns
t <sub>f DO</sub>	DO fall time	$C_L = 100 \text{ pF}, I_{load} = 1 \text{ mA}$	-	50	100	ns
t <sub>en DO tri L</sub>	DO enable time from 3-state to low-level	$C_L = 100 \text{ pF, } I_{load} = 1 \text{ mA}$ pull up load to $V_{CC}$	-	100	250	ns
t <sub>dis DO L tri</sub>	DO disable time from low-level to 3-state	$C_L = 100 \text{ pF, } I_{load} = 4 \text{ mA}$ pull up load to $V_{CC}$	-	380	450	ns
t <sub>en DO tri H</sub>	DO enable time from 3-state to high- level	C <sub>L</sub> =100 pF, I <sub>load</sub> = -1 mA pull down load to GND		100	250	ns
t <sub>dis DO H tri</sub>	DO disable time from high-level to 3- state	$IC_1 = 100 \text{ pF } I_{\text{max}} = -4 \text{ mA pull}$		380	450	ns
t <sub>d DO</sub>	DO delay time	$V_{DO} < 0.3 V_{CC}, V_{DO} > 0.7 V_{CC},$ $C_L = 100 pF$		50	250	ns

Table 17. CSN timing

Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
t <sub>CSN_HI,stb</sub>	CSN HI time, switching from standby mode	Transfer of SPI command to Input Register	20	-	-	μs
t <sub>CSN_HI,min</sub>	CSN HI time, active mode	Transfer of SPI command to input register	4	-	1	μs

Figure 3. SPI - transfer timing diagram

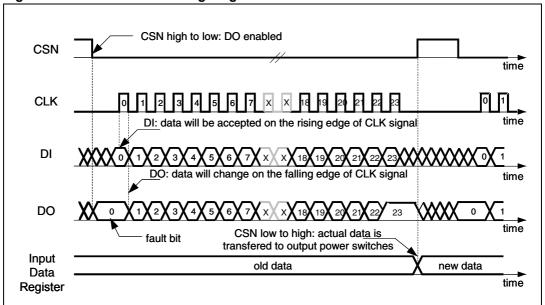
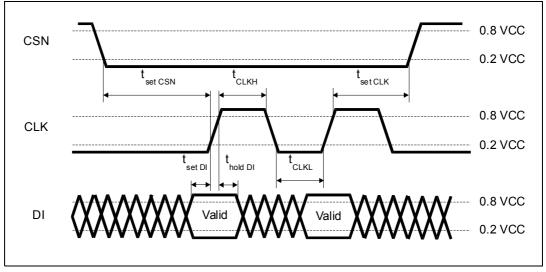


Figure 4. SPI - input timing



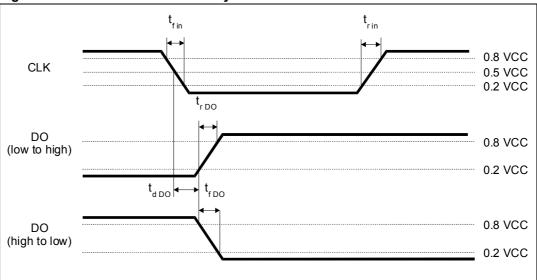
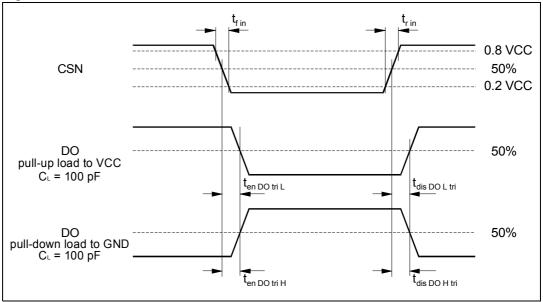


Figure 5. SPI - DO valid data delay time and valid time





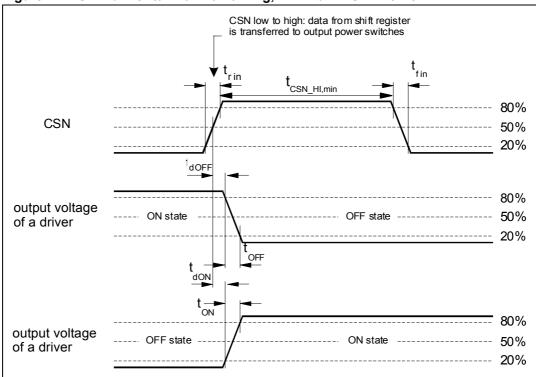
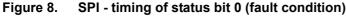
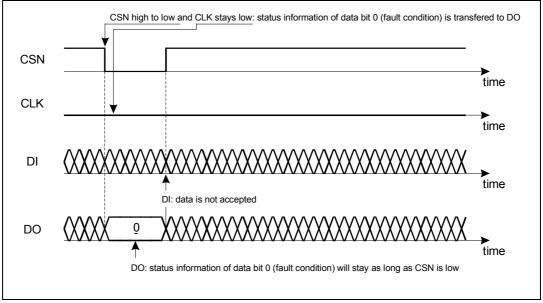


Figure 7. SPI - driver turn-on / off timing, minimum CSN HI time





# 3 Application information

### 3.1 Dual power supply: $V_S$ and $V_{CC}$

The power supply voltage  $V_S$  supplies the half bridges and the high-side drivers. An internal charge-pump is used to drive the high-side switches. The logic supply voltage  $V_{CC}$  (stabilized 5 V) is used for the logic part and the SPI of the device.

Due to the independent logic supply voltage the control and status information not are lost, if there are temporary spikes or glitches on the power supply voltage. In case of power-on ( $V_{CC}$  increases from under voltage to  $V_{POR\ Off} = 4.2\ V$ ) the circuit is initialized by an internally generated power-on-reset (POR). If the voltage  $V_{CC}$  decreases under the minimum threshold ( $V_{POR\ ON} = 3.4\ V$ ), the outputs are switched to 3-state (high impedance) and the status registers are cleared.

### 3.2 Standby mode

The standby mode of the L9954LXP is activated by clearing the bit 23 of the input data register 0. All latched data is cleared and the inputs and outputs are switched to high impedance. In the standby mode the current at  $V_S$  ( $V_{CC}$ ) is less than 6  $\mu$ A (50 $\mu$ A) for CSN = high (DO in 3-state). By switching the  $V_{CC}$  voltage a very low quiescent current can be achieved. If bit 23 is set, the device is switched to active mode.

#### 3.3 Inductive loads

Each half bridge is built by an internally connected high-side and a low-side power DMOS transistor. Due to the built-in reverse diodes of the output transistors, inductive loads can be driven at the outputs OUT1 to OUT3 without external free-wheeling diodes. The high-side drivers OUT4 to OUT6 are intended to drive resistive loads. Hence only a limited energy (E<1mJ) can be dissipated by the internal ESD-diodes in freewheeling condition. For inductive loads (L>100 $\mu$ H) an external free-wheeling diode connected to GND and the corresponding output is needed.

# 3.4 Diagnostic functions

All diagnostic functions (over/open-load, power supply over-/under voltage, temperature warning and thermal shutdown) are internally filtered and the condition has to be valid for at least 32 µs (open-load: 1ms, respectively) before the corresponding status bit in the status registers is set. The filters are used to improve the noise immunity of the device. Open-load and temperature warning function are intended for information purpose and not changes the state of the output drivers. On contrary, the overload condition disables the corresponding driver (over-current) and overtemperature switchs off all drivers (thermal shutdown). Without setting the over-current recovery bits in the input data register, the microcontroller has to clear the over-current status bits to reactivate the corresponding drivers.

20/35 Doc ID 16186 Rev 2

#### 3.5 Overvoltage and under voltage detection

If the power supply voltage  $V_S$  rises above the overvoltage threshold  $V_{SOV\ Off}$  (typical 21 V), the outputs OUT1 to OUT6 are switched to high impedance state to protect the load. When the voltage  $V_S$  drops below the under voltage threshold  $V_{SUV\ Off}$  (UV-switch-off voltage), the output stages are switched to the high impedance to avoid the operation of the power devices without sufficient gate driving voltage (increased power dissipation). If the supply voltage  $V_S$  recovers (register 0: bit 20=0) to normal operating voltage the outputs stages return to the programmed state after at least 32  $\mu_S$ .

If the under voltage/overvoltage recovery disable bit is set, the automatic turn-on of the drivers is deactivated. The microcontroller needs to clear the status bits to reactivate the drivers. It is strongly recommended to set bit 20 to avoid a possible high current oscillation in case of a shorted output to GND and low battery voltage.

# 3.6 Charge pump

The charge pump runs under all conditions in normal mode. In standby the charge pump is out of action.

### 3.7 Temperature warning and thermal shutdown

If junction temperature rises above  $T_{j\ TW}$  a temperature warning flag is set after at least 32  $\mu s$  and is detectable via the SPI. If junction temperature increases above the second threshold  $T_{j\ SD}$ , the thermal shutdown bit is set and power DMOS transistors of all output stages are switched off to protect the device after at least 32  $\mu s$ . Temperature warning flag and thermal shutdown bit are latched and must be cleared by the microcontroller. The related bit is only cleared if the temperature decreases below the trigger temperature. If the thermal shutdown bit has been cleared the output stages are reactivated.

### 3.8 Open-load detection

The open-load detection monitors the load current in each activated output stage. If the load current is below the open-load detection threshold for at least 1 ms ( $t_{dOL}$ ) the corresponding open-load bit is set in the status register. Due to mechanical/electrical inertia of typical loads a short activation of the outputs (e.g. 3 ms) can be used to test the open-load status without changing the mechanical/electrical state of the loads.

#### 3.9 Overload detection

In case of an over-current condition a flag is set in the status register in the same way as open-load detection. If the over-current signal is valid for at least  $t_{\rm ISC}=32~\mu s$ , the over-current flag is set and the corresponding driver is switched off to reduce the power dissipation and to protect the integrated circuit. If the over-current recovery bit of the output is zero the microcontroller has to clear the status bits to reactivate the corresponding driver.

#### 3.10 Current monitor

The current monitor output sources a current image at the current monitor output which has a fixed ratio (1/10000) of the instantaneous current of the selected high-side driver. Signal at output CM is blanked after switching on of driver until correct settlement of circuitry (at least for 32 µs).

The bits 18 and 19 of the input data register 0 control which of the outputs OUT1, OUT4, OUT5 and OUT6 is multiplexed to the current monitor output. The current monitor output allows a more precise analysis of the actual state of the load rather than the detection of an open- or overload condition. For example this can be used to detect the motor state (starting, free-running, stalled). Moreover, it is possible to regulate the power of the defroster more precise by measuring the load current. The current monitor output is bidirectional (c.f. PWM inputs).

# 3.11 PWM inputs

Each driver has a corresponding PWM enable bit which can be programmed by the SPI interface. If the PWM enable bit in Input data register 1 is set, the output is controlled by the logically AND-combination of the PWM signal and the output control bit in input data register 0. The outputs OUT1-OUT4 and OUT6 are controlled by the PWM1 input and the output OUT5 is controlled by the bidirectional input CM/PMW2. For example, the two PWM inputs can be used to dim two lamps independently by external PWM signals.

# 3.12 Cross-current protection

The three half-bridges of the device are cross-current protected by an internal delay time. If one driver (LS or HS) is turned-off the activation of the other driver of the same half bridge is automatically delayed by the cross-current protection time. After the cross-current protection time is expired the slew-rate limited switch-off phase of the driver is changed to a fast turn-off phase and the opposite driver is turned-on with slew-rate limitation. Due to this behavior it is always guaranteed that the previously activated driver is totally turned-off before the opposite driver starts to conduct.

22/35 Doc ID 16186 Rev 2

# 3.13 Programmable soft start function to drive loads with higher inrush current

Loads with start-up currents higher than the overcurrent limits (e.g. inrush current of lamps, start current of motors and cold resistance of heaters) can be driven by using the programmable soft start function (i.e. overcurrent recovery mode). Each driver has a corresponding over-current recovery bit. If this bit is set, the device switchs automatically on the outputs again after a programmable recovery time. The duty cycle in over-current condition can be programmed by the SPI interface to be about 15 %...25 %. The PWM modulated current provides sufficient average current to power up the load (e.g. heat up the bulb) until the load reaches operating condition. The PWM frequency settles at 1.5 kHz or 3 kHz. The device itself cannot distinguish between a real overload and a non linear load like a light bulb. A real overload condition can only be qualified by time. As an example the microcontroller can switch on light bulbs by setting the over-current recovery bit for the first 50ms. After clearing the recovery bit the output is automatically disabled if the overload condition still exits.

Load Current
Unlimited Inrush Current in overcurrent recovery mode with inductive load

Overcurrent detection

Limited Inrush Current in overcurrent recovery mode with incandescent bulb

Figure 9. Programmable soft start function for inductive loads and incandescent bulbs

# 4 Functional description of the SPI

#### 4.1 Serial Peripheral Interface (SPI)

This device uses a standard SPI to communicate with a microcontroller. The SPI can be driven by a microcontroller with its SPI peripheral running in following mode: CPOL = 0 and CPHA = 0.

For this mode, input data is sampled by the low to high transition of the clock CLK, and output data is changed from the high to low transition of CLK.

This device is not limited to microcontroller with a build-in SPI. Only three CMOS compatible output pins and one input pin are needed to communicate with the device. A fault condition can be detected by setting CSN to low. If CSN = 0, the DO pin reflects the status bit 0 (fault condition) of the device which is a logical-or of all bits in the status registers 0 and 1. The microcontroller can poll the status of the device without the need of a full SPI communication cycle.

Note: In contrast to the SPI standard the least significant bit (LSB) is transferred first (see Figure 3).

### 4.2 Chip Select Not (CSN)

The input pin is used to select the serial interface of this device. When CSN is high, the output pin (DO) is in high impedance state. A low signal activates the output driver and a serial communication can be started. The state when CSN is going low until the rising edge of CSN is called a communication frame.

# 4.3 Serial Data In (DI)

The input pin is used to transfer data serial into the device. The data applied to the DI is sampled at the rising edge of the CLK signal and shifted into an internal 24 bit shift register. At the rising edge of the CSN signal the contents of the shift register is transferred to data input register. The writing to the selected data input register is only enabled if exactly 24 bits are transmitted within one communication frame (i.e. CSN low). If more or less clock pulses are counted within one frame the complete frame is ignored. This safety function is implemented to avoid an activation of the output stages by a wrong communication frame.

Note: Due to this safety functionality a daisy chaining of SPI is not possible. Instead, a parallel operation of the SPI bus by controlling the CSN signal of the connected ICs is recommended.

# 4.4 Serial Data Out (DO)

The data output driver is activated by a logical low-level at the CSN input and goes from high impedance to a low or high-level depending on the status bit 0 (fault condition). The first rising edge of the CLK input after a high to low transition of the CSN pin transfers the content of the selected status register into the data out shift register. Each subsequent falling edge of the CLK shifts the next bit out.

#### 4.5 Serial Clock (CLK)

The CLK input is used to synchronize the input and output serial bit streams. The data input (DI) is sampled at the rising edge of the CLK and the data output (DO) changes with the falling edge of the CLK signal.

### 4.6 Input Data Register

The device has two input registers. The first bit (bit 0) at the DI input is used to select one of the two input registers. All bits are first shifted into an input shift register. After the rising edge of CSN the contents of the input shift register is written to the selected input data register only if a frame of exact 24 data bits are detected. Depending on bit 0 the contents of the selected status register is transferred to DO during the current communication frame. Bit 1-17 controls the behavior of the corresponding driver.

If bit 23 is zero, the device goes into the standby mode. The bits 18 and 19 are used to control the current monitor multiplexer. Bit 22 is used to reset all status bits in both status registers. The bits in the status registers is cleared after the current communication frame (rising edge of CSN).

# 4.7 Status register

This devices uses two status registers to store and to monitor the state of the device. No error bit (bit 0) is used as a fault bit and is a logical-NOR combination of bits 1-22 in both status registers. The state of this bit can be polled by the microcontroller without the need of a full SPI communication cycle. If one of the over-current bits is set, the corresponding driver is disabled. If the over-current recovery bit of the output is not set the microcontroller has to clear the over-current bit to enable the driver. If the thermal shutdown bit is set, all drivers goes into a high impedance state. Again the microcontroller has to clear the bit to enable the drivers.

# 4.8 SPI - input data and status registers

Table 18. SPI - input data and status registers 0

Bit		Input register 0 (write)		Status register 0 (read)			
ы	Na	me	Comment		Name	Comment	
23	Enable bit		If enable bit is set the device switches in active mode. If enable bit is cleared the device goes into standby mode and all bits are cleared. After power-on reset device starts in standby mode.		Always 1	A broken V <sub>CC</sub> -or SPI connection of the L9954LXP can be detected by the microcontroller, because all 24 bits low or high is not a valid frame.	
22	Reset bit		status	registe d after r	set both rs are ising edge of	V <sub>S</sub> overvoltage	In case of an overvoltage or undervoltage event the corresponding bit is set and the outputs are deactivated. If
	OC recovery duty cycle This bit defines in combination with		vith the over-		V <sub>S</sub> voltage recovers to normal operating conditions outputs		
21	0: 12%	1: 25%	registe in over	r 1) the	ery bit (input e duty cycle condition of driver.	V <sub>S</sub> undervoltage	are reactivated automatically (if bit 20 of status register 0 is not set).
20		•	If this bit is set the microcontroller has to clear the status register after under voltage / overvoltage event to enable the outputs.		Thermal shutdown	In case of a thermal shutdown all outputs are switched off. The microcontroller has to clear the TSD bit by setting the Reset Bit to reactivate the outputs.	
19			combin 19 the (1/10.0 HS-ou	current 000) of	of bit 18 and t image the selected multiplexed	Temperature warning	The TW bit can be used for thermal management by the microcontroller to avoid a thermal shutdown. The microcontroller has to clear the TW bit.
	Current monitor select bits		Bit 19	Bit 18	Output		After switching the device from standby mode to active mode
			0	0	OUT6		an internal timer is started to allow charge pump to settle
			1	0	OUT1		before the outputs can be activated. This bit is cleared
18			0	1	OUT4	Not ready bit	automatically after start up
			1	1	OUT5		time has finished. Since this bit is controlled by internal clock it can be used for synchronizing testing events (e.g. measuring filter times).

Table 18. SPI - input data and status registers 0 (continued)

D:4	Input	register 0 (write)	Statı	us register 0 (read)
Bit	Name	Comment	Name	Comment
17	OUT6 – HS on/off		OUT6 – HS over-current	
16	x (don't care)		0	
15	OUT5 – HS on/off		OUT5 – HS over-current	
14	OUT4 – HS on/off	If a bit is set the selected	OUT4 – HS over-current	
13	x (don't care)	output driver is switched	0	In case of an over-current
12	x (don't care)	on. If the corresponding PWM enable bit is set	0	event the corresponding status bit is set and the output driver
11	x (don't care)	(input register 1) the driver is only activated if PWM1 (PWM2) input signal is high. The outputs of	0	is disabled. If the over-current
10	x (don't care)		0	recovery enable bit is set (input register 1) the output is
9	x (don't care)		0	automatically reactivated after
8	x (don't care)	OUT1-OUT3 are half bridges. If the bits of HS-	0	a delay time resulting in a PWM modulated current with a
7	x (don't care)	and LS-driver of the same half bridge are set, the internal logic prevents that both drivers of this output stage can be switched on simultaneously in order to	0	programmable duty cycle (bit
6	OUT3 – HS on/off		OUT3 – HS over-current	21). If the over-current recovery bit is not set the microcontroller
5	OUT3 – LS on/off		OUT3 – LS over-current	has to clear the over-current bit (reset bit) to reactivate the
4	OUT2 – HS on/off	avoid a high internal current from V <sub>S</sub> to GND.	OUT2 – HS over-current	output driver.
3	OUT2 – LS on/off		OUT2 – LS over-current	
2	OUT1 – HS on/off		OUT1 – HS over-current	
1	OUT1 – LS on/off		OUT1 – LS over-current	
0		0	No error bit	A logical NOR-combination of all bits 1 to 22 in both status registers.

Table 19. SPI - input data and status registers 1

Bit	Inp	ut register 1 (write)	Status re	egister 1 (read)
БІІ	Name	Comment	Name	Comment
23	Enable bit	If enable bit is set the device is switched in active mode. If enable bit is cleared device goes into standby mode and all bits are cleared. After poweron reset device starts in standby mode.	Always 1	A broken V <sub>CC</sub> or SPI connection of the L9954LXP can be detected by the microcontroller, because all 24 bits low or high is not a valid frame.
22	OUT6 OC recovery enable		V <sub>S</sub> overvoltage	In case of an overvoltage or under voltage event the corresponding bit is
21	x (don't care)	In case of an over-current event the over-current status bit (status register 0) is set and the output is switched off. If the over current recovery enable bit is set the output is automatically reactivated after a delay time resulting in a PWM modulated current with a programmable duty cycle (bit 21 of input data register 0). Depending on occurrence of overcurrent event and internal clock phase it is possible that one recovery cycle is executed even if this bit is set to zero.	V <sub>S</sub> undervoltage	set and the outputs are deactivated. If V <sub>S</sub> voltage recovers to normal operating conditions outputs are reactivated automatically.
20	OUT5 OC recovery enable		Thermal shutdown	In case of a thermal shutdown all outputs are switched off. The microcontroller has to clear the TSD bit by setting the reset bit to reactivate the outputs.
19	OUT4 OC recovery enable		Temperature warning	The TW bit can be used for thermal management by the microcontroller to avoid a thermal shutdown. The microcontroller has to clear the TW bit.
18	x (don't care)		Not ready bit	After switching the device from standby mode to active mode an internal timer is started to allow charge pump to settle before the outputs can be activated. This bit is only present during start up time.  Since this bit is controlled by internal clock it can be used for synchronizing testing events(e.g. measuring filter times).

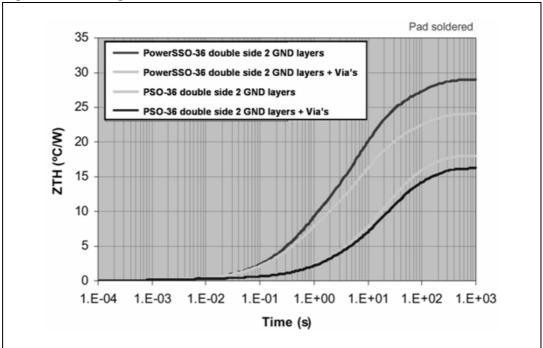
Table 19. SPI - input data and status registers 1 (continued)

Bit	Inp	ut register 1 (write)	Status i	register 1 (read)
ы	Name	Comment	Name	Comment
17	Enable high R <sub>DSon</sub> OUT5		OUT6 – HS open-load	
16	x (don't care)		0	
15	x (don't care)		OUT5 – HS open-load	
14	OUT3 OC recovery enable	After 50ms the bit can be cleared. If over-current condition still exists, a wrong load can be assumed.	OUT4 – HS open-load	
13	OUT2 OC recovery enable	load can be assumed.	0	The open-load detection monitors the load current
12	OUT1 OC recovery enable		0	in each activated output stage. If the load current is below the open-load
11	OUT6 PWM1 enable		0	detection threshold for at least 1 ms (t <sub>dOL</sub> ) the
10	x (don't care)	If the PWM1/2 enable bit is set	0	corresponding open-load bit is set. Due to
9	OUT5 PWM2 enable		0	mechanical/electrical inertia of typical loads a
8	OUT4 PWM1 enable			0
7	x (don't care)	and the output is enabled	0	load status without
6	Enable high R <sub>DSon</sub> OUT4	(input register 0) the output is switched on if PWM1/2 input is high and switched off if	OUT3 – HS open-load	changing the mechanical/electrical
5	x (don't care)	PWM1/2 input is low. OUT5 is controlled by PWM2 input. All	OUT3 – LS open-load	state of the loads.
4	x (don't care)	other outputs are controlled by PWM1 input.	OUT2 -HS open-load	
3	OUT3 PWM1 enable		OUT2- LS open-load	
2	OUT2 PWM1 enable		OUT1 – HS open-load	
1	OUT1 PWM1 enable		OUT1 – LS open-load	
0		1	No error bit	A logical NOR- combination of all bits 1 to 22 in both status registers.

**577** 

# 5 Packages thermal data





# 6 Package and packing information

# 6.1 ECOPACK® packages

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: <a href="https://www.st.com">www.st.com</a>.

ECOPACK® is an ST trademark.

# 6.2 PowerSSO-36 package information

Figure 11. PowerSSO-36 package dimensions

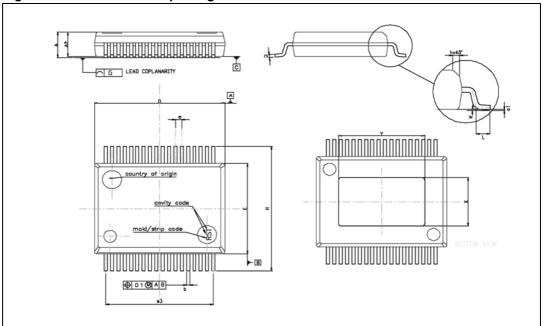


Table 20. PowerSSO-36 mechanical data

Comple of	Millimeters				
Symbol	Min.	Тур.	Max.		
А	2.15	-	2.47		
A2	2.15	-	2.40		
a1	0	-	0.075		
b	0.18	-	0.36		
С	0.23	-	0.32		
D	10.10	-	10.50		
E	7.4	-	7.6		
е	-	0.5	-		
e3	-	8.5	-		
G	-	-	0.1		
G1	-	-	0.06		
Н	10.1	-	10.5		
h	-	-	0.4		
L	0.55	-	0.85		
N	-	-	10 deg		
Х	4.3	-	5.2		
Υ	6.9	-	7.5		

# 6.3 PowerSSO-36 packing information

Figure 12. PowerSSO-36 tube shipment (no suffix)

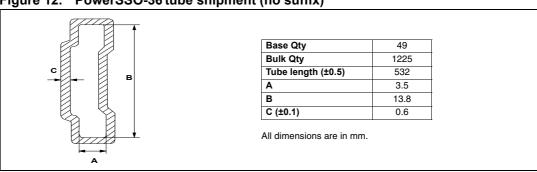
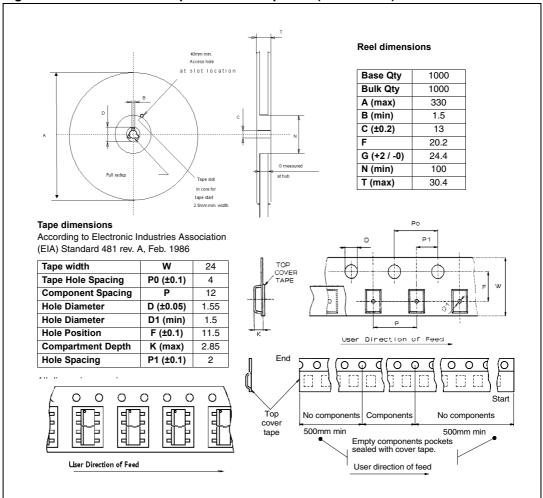


Figure 13. PowerSSO-36 tape and reel shipment (suffix "TR")



Revision history L9954LXP

# 7 Revision history

Table 21. Document revision history

Date	Revision	Description of changes
12-Feb-2010	1	Initial release.
17-May-2010	2	Table 20: PowerSSO-36 mechanical data:  - Changed X: minimum value from 4.1 to 4.3 and maximum value from 4.7 to 5.2  - Changed Y: minimum value from 6.5 to 6.9 and maximum value from 7.1 to 7.5

#### Please Read Carefully:

Information in this document is provided solely in connection with ST products. STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, modifications or improvements, to this document, and the products and services described herein at any time, without notice.

All ST products are sold pursuant to ST's terms and conditions of sale.

Purchasers are solely responsible for the choice, selection and use of the ST products and services described herein, and ST assumes no liability whatsoever relating to the choice, selection or use of the ST products and services described herein.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted under this document. If any part of this document refers to any third party products or services it shall not be deemed a license grant by ST for the use of such third party products or services, or any intellectual property contained therein or considered as a warranty covering the use in any manner whatsoever of such third party products or services or any intellectual property contained therein.

UNLESS OTHERWISE SET FORTH IN ST'S TERMS AND CONDITIONS OF SALE ST DISCLAIMS ANY EXPRESS OR IMPLIED WARRANTY WITH RESPECT TO THE USE AND/OR SALE OF ST PRODUCTS INCLUDING WITHOUT LIMITATION IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION), OR INFRINGEMENT OF ANY PATENT, COPYRIGHT OR OTHER INTELLECTUAL PROPERTY RIGHT.

UNLESS EXPRESSLY APPROVED IN WRITING BY AN AUTHORIZED ST REPRESENTATIVE, ST PRODUCTS ARE NOT RECOMMENDED, AUTHORIZED OR WARRANTED FOR USE IN MILITARY, AIR CRAFT, SPACE, LIFE SAVING, OR LIFE SUSTAINING APPLICATIONS, NOR IN PRODUCTS OR SYSTEMS WHERE FAILURE OR MALFUNCTION MAY RESULT IN PERSONAL INJURY, DEATH, OR SEVERE PROPERTY OR ENVIRONMENTAL DAMAGE. ST PRODUCTS WHICH ARE NOT SPECIFIED AS "AUTOMOTIVE GRADE" MAY ONLY BE USED IN AUTOMOTIVE APPLICATIONS AT USER'S OWN RISK.

Resale of ST products with provisions different from the statements and/or technical features set forth in this document shall immediately void any warranty granted by ST for the ST product or service described herein and shall not create or extend in any manner whatsoever, any liability of ST.

ST and the ST logo are trademarks or registered trademarks of ST in various countries.

Information in this document supersedes and replaces all information previously supplied.

The ST logo is a registered trademark of STMicroelectronics. All other names are the property of their respective owners.

© 2010 STMicroelectronics - All rights reserved

STMicroelectronics group of companies

Australia - Belgium - Brazil - Canada - China - Czech Republic - Finland - France - Germany - Hong Kong - India - Israel - Italy - Japan - Malaysia - Malta - Morocco - Philippines - Singapore - Spain - Sweden - Switzerland - United Kingdom - United States of America

www.st.com

